

TSE ANKARA LABORATORIES
CALIBRATION ACCREDITATION SCOPE

MEASURAND /DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
ELEKTRİK				
DC VOLTAGE (< 1000 V) DC VOLTAGE Source: DC VOLTAGE Source Calibrator: DC	100 $\mu\text{V} \leq U < 100\text{mV}$ 100 $\text{mV} \leq U < 1\text{V}$ 1 $\text{V} \leq U \leq 10\text{V}$ 10 $\text{V} < U \leq 100\text{V}$ 100 $\text{V} < U \leq 1000\text{V}$		$2,5 \cdot 10^{-5} U + 2 \mu\text{V}$ $7 \cdot 10^{-6} U + 20 \mu\text{V}$ $6 \cdot 10^{-6} U + 7 \mu\text{V}$ $8,5 \cdot 10^{-6} U + 110 \mu\text{V}$ $8 \cdot 10^{-6} U + 900 \mu\text{V}$	With 3458A
DC VOLTAGE (< 1000V) DC VOLTAGE Source: DC VOLTAGE Source Calibrator: DC	10 mV 100 mV 1 V 10V ,100V ,1000V		$1,0 \cdot 10^{-4} \cdot U$ $1,5 \cdot 10^{-5} \cdot U$ $4,0 \cdot 10^{-6} \cdot U$ $2,0 \cdot 10^{-6} \cdot U$	With Reference DC VOLTAGE Standard + VOLTAGE Divider
DC VOLTAGE (< 1000V) DC VOLTAGE Monitors: Multimeter: DC VOLTAGE DC Voltmetre	100 $\mu\text{V} \leq U < 220\text{mV}$ 220 $\text{mV} \leq U \leq 2,2 \text{ V}$ 2,2 $\text{V} < U \leq 11 \text{ V}$ 11 $\text{V} < U \leq 22 \text{ V}$ 22 $\text{V} < U \leq 220 \text{ V}$ 220 $\text{V} < U \leq 1000 \text{ V}$		$2 \cdot 10^{-5} \cdot U + 2 \mu\text{V}$ $1 \cdot 10^{-5} \cdot U + 5 \mu\text{V}$ $1 \cdot 10^{-5} \cdot U + 25 \mu\text{V}$ $1 \cdot 10^{-5} \cdot U + 90 \mu\text{V}$ $1 \cdot 10^{-5} \cdot U + 300 \mu\text{V}$ $1 \cdot 10^{-5} \cdot U + 3 \text{ mV}$	With 5700A
DC VOLTAGE (< 1000V) DC VOLTAGE Monitors: Multimeter: DC VOLTAGE DC Voltmetre	10 mV 100 mV 1 V 10V ,100V ,1000V		$1,2 \cdot 10^{-4} \cdot U$ $1,2 \cdot 10^{-5} \cdot U$ $4,0 \cdot 10^{-6} \cdot U$ $2,0 \cdot 10^{-6} \cdot U$	With Reference DC VOLTAGE Standard + VOLTAGE Divider

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DC Current (< 100 A) DC Current Source: DC Current Source Calibrator: DC Current Transconductance Amplifier	$100 \mu\text{A} \leq I \leq 1 \text{ mA}$ $1 \text{ mA} < I \leq 10 \text{ mA}$ $10 \text{ mA} < I \leq 100 \text{ mA}$ $100 \text{ mA} < I \leq 1 \text{ A}$ $100 \mu\text{A} \leq I < 1 \text{ mA}$ $10 \text{ mA} < I \leq 1 \text{ A}$ $1 \text{ A} < I \leq 10 \text{ A}$ $10 \text{ A} < I \leq 15 \text{ A}$ $15 \text{ A} < I \leq 20 \text{ A}$ $10 \text{ A} < I \leq 150 \text{ A}$ $150 \text{ A} < I \leq 550 \text{ A}$ $550 \text{ A} < I \leq 1025 \text{ A}$		$3,5 \cdot 10^{-5} \cdot I + 10 \text{ nA}$ $3,5 \cdot 10^{-5} \cdot I + 150 \text{ nA}$ $5,5 \cdot 10^{-5} \cdot I + 1 \mu\text{A}$ $1,5 \cdot 10^{-4} \cdot I + 25 \mu\text{A}$ $1 \cdot 10^{-5} \cdot I$ $2 \cdot 10^{-5} \cdot I$ $6,5 \cdot 10^{-5} \cdot I + 140 \mu\text{A}$ $8,5 \cdot 10^{-5} \cdot I$ $1,2 \cdot 10^{-4} \cdot I$ $2,8 \cdot 10^{-2} \cdot I + 0,82 \text{ A}$ $2,8 \cdot 10^{-2} \cdot I$ $2,5^{-2} \cdot I$	With 3458A DMM With Current Shunt With Fluke 376
DC Current (< 100 A) DC Current Monitors: Multimeter: DC Current DC Ammeter Clampmeter	$100 \mu\text{A} \leq I < 220 \mu\text{A}$ $220 \mu\text{A} \leq I < 2,2 \text{ mA}$ $2,2 \text{ mA} \leq I < 22 \text{ mA}$ $22 \text{ mA} \leq I < 220 \text{ mA}$ $220 \text{ mA} \leq I \leq 2,2 \text{ A}$ $2,2 \text{ A} < I \leq 11 \text{ A}$ $11 \text{ A} < I \leq 20 \text{ A}$ $100 \mu\text{A} \leq I \leq 10 \text{ mA}$ $10 \text{ mA} < I \leq 1 \text{ A}$ $1 \text{ A} < I \leq 10 \text{ A}$ $10 \text{ A} < I \leq 15 \text{ A}$ $15 \text{ A} < I \leq 20 \text{ A}$ $10 \text{ A} \leq I \leq 1000 \text{ A}$		$9 \cdot 10^{-5} \cdot I + 15 \text{ nA}$ $6 \cdot 10^{-5} \cdot I + 25 \text{ nA}$ $6 \cdot 10^{-5} \cdot I + 250 \text{ nA}$ $7 \cdot 10^{-5} \cdot I + 2.5 \mu\text{A}$ $1,3 \cdot 10^{-4} \cdot I + 45 \mu\text{A}$ $6 \cdot 10^{-4} \cdot I$ $4 \cdot 10^{-4} \cdot I$ $1 \cdot 10^{-5} \cdot I$ $2 \cdot 10^{-5} \cdot I$ $6,5 \cdot 10^{-5} \cdot I + 140 \mu\text{A}$ $8,5 \cdot 10^{-5} \cdot I$ $1,2 \cdot 10^{-4} \cdot I$ $5 \cdot 10^{-3} \cdot I$	With 5700A With 5520A With 5700A + 5220A With Current Clampmeter Calibration (With 5520A + 50 Turn Coil

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DC Resistance	100 $\mu\Omega$	$I_{max} = 60 \text{ A}$	$5 \cdot 10^{-3} \cdot R$	R = Measured Value
DC Resistance	1 m Ω	$I_{max} = 30 \text{ A}$	$7 \cdot 10^{-5} \cdot R$	
Measuring Instruments:	10 m Ω	$I_{max} = 20 \text{ A}$	$5 \cdot 10^{-5} \cdot R$	
Multimeter:	100 m Ω	$I_{max} = 1 \text{ A}$	$2 \cdot 10^{-5} \cdot R$	
Microohmmeter	1 Ω	$I_{max} = 0,32 \text{ A}$	$5 \cdot 10^{-6} \cdot R$	
Insulation	10 Ω	$I_{max} = 0,1 \text{ A}$	$5 \cdot 10^{-6} \cdot R$	
Resistance Tester	100 Ω	$I_{max} = 32 \text{ mA}$	$5 \cdot 10^{-6} \cdot R$	
	1 k Ω	$I_{max} = 10 \text{ mA}$	$5 \cdot 10^{-6} \cdot R$	
	10 k Ω	$I_{max} = 3,2 \text{ mA}$	$5 \cdot 10^{-6} \cdot R$	
	100 k Ω	$I_{max} = 1 \text{ mA}$	$5 \cdot 10^{-6} \cdot R$	
	1 M Ω	$V_{max} = 320 \text{ V}$	$1 \cdot 10^{-5} \cdot R$	
	10 M Ω	$V_{max} = 1000 \text{ V}$	$1,5 \cdot 10^{-5} \cdot R$	
	100 M Ω	$V_{max} = 1000 \text{ V}$	$2,5 \cdot 10^{-5} \cdot R$	
	$0,1 \Omega \leq R < 1 \Omega$	$I_{max} = 2 \text{ A}$	$8 \cdot 10^{-4} \cdot R$	
	$1 \Omega \leq R \leq 100 \text{ k}\Omega$	1 Ω -10 Ω ($I_{max} = 600 \text{ mA}$) 10 Ω -100 Ω ($I_{max} = 200 \text{ mA}$) 100 Ω -1 k Ω ($I_{max} = 60 \text{ mA}$) 1 k Ω -10 k Ω ($I_{max} = 20 \text{ mA}$) 10 k Ω -100 k Ω ($I_{max} = 6 \text{ mA}$)	$1,5 \cdot 10^{-4} \cdot R$	R = Measured Value

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DC Resistance DC Resistance Ölçerler Multimeter: Resistance Microohmmeter Insulation resistance Tester	$1\Omega \leq R < 11\Omega$	$1 \text{ mA} \leq I_{\text{max}} \leq 125 \text{ mA}$	$7,4 \cdot 10^{-4} + 8 \text{ m}\Omega$	With 5520A R = Measured Value
	$11\Omega \leq R < 33\Omega$	$1 \text{ mA} \leq I_{\text{max}} \leq 125 \text{ mA}$	$3,5 \cdot 10^{-4} + 12 \text{ m}\Omega$	
	$33\Omega \leq R < 110\Omega$	$1 \text{ mA} \leq I_{\text{max}} \leq 70 \text{ mA}$	$1,3 \cdot 10^{-4} + 15 \text{ m}\Omega$	
	$110\Omega \leq R < 330\Omega$	$1 \text{ mA} \leq I_{\text{max}} \leq 40 \text{ mA}$	$7,1 \cdot 10^{-5} + 20 \text{ m}\Omega$	
	$330\Omega \leq R \leq 1,1\text{k}\Omega$	$1 \text{ mA} \leq I_{\text{max}} \leq 18 \text{ mA}$	$4 \cdot 10^{-5} + 25 \text{ m}\Omega$	
	$1,1\text{k}\Omega < R \leq 3,3\text{k}\Omega$	$100 \mu\text{A} \leq I_{\text{max}} \leq 5 \text{ mA}$	$7,1 \cdot 10^{-5} + 200 \text{ m}\Omega$	
	$3,3\text{k}\Omega < R \leq 11\text{k}\Omega$	$100 \mu\text{A} \leq I_{\text{max}} \leq 1,8\text{mA}$	$3,4 \cdot 10^{-5} + 200 \text{ m}\Omega$	
	$11\text{k}\Omega < R \leq 33\text{k}\Omega$	$10 \mu\text{A} \leq I_{\text{max}} \leq 0,5 \text{ mA}$	$5,2 \cdot 10^{-5} + 1,2 \Omega$	
	$33\text{k}\Omega < R < 110\text{k}\Omega$	$10 \mu\text{A} \leq I_{\text{max}} \leq 0,18\text{mA}$	$6,2 \cdot 10^{-5} + 6,0 \Omega$	
	$110\text{k}\Omega \leq R < 330\text{k}\Omega$	$10 \mu\text{A} \leq I_{\text{max}} \leq 50 \mu\text{A}$	$5,8 \cdot 10^{-5} + 13 \Omega$	
	$330\text{k}\Omega \leq R \leq 1,1\text{M}\Omega$	$1 \mu\text{A} \leq I_{\text{max}} \leq 50 \mu\text{A}$	$4,2 \cdot 10^{-5} + 20 \Omega$	
	$1,1\text{M}\Omega < R < 3,3\text{M}\Omega$	$250 \text{ nA} \leq I_{\text{max}} \leq 5 \mu\text{A}$	$1,0 \cdot 10^{-4} + 200 \Omega$	
	$3,3\text{M}\Omega < R \leq 11\text{M}\Omega$	$25 \text{ nA} \leq I_{\text{max}} \leq 1,8 \mu\text{A}$	$1,3 \cdot 10^{-4} + 550 \Omega$	
	$11\text{M}\Omega < R \leq 33\text{M}\Omega$	$25 \text{ nA} \leq I_{\text{max}} \leq 500 \text{ nA}$	$3,0 \cdot 10^{-4} + 4,2 \text{ k}\Omega$	
	$33\text{M}\Omega < R \leq 110\text{M}\Omega$	$2,5 \text{ nA} \leq I_{\text{max}} \leq 50 \text{ nA}$	$5,0 \cdot 10^{-4} + 21 \text{ k}\Omega$	
	$110 \text{ M}\Omega \leq R < 330\text{M}\Omega$	$2,5 \text{ nA} \leq I_{\text{max}} \leq 50 \text{ nA}$	$3,5 \cdot 10^{-3} \cdot R$	
	$330\text{M}\Omega \leq R \leq 1100\text{M}\Omega$	$1,0 \text{ nA} \leq I_{\text{max}} \leq 13 \text{ nA}$	$1,5 \cdot 10^{-2} \cdot R$	
			$2 \cdot 10^{-4} \cdot R$	
			$4 \cdot 10^{-5} \cdot R$	
			$2 \cdot 10^{-5} \cdot R$	
			$2 \cdot 10^{-5} \cdot R$	
			$2 \cdot 10^{-5} \cdot R$	
			$3 \cdot 10^{-5} \cdot R$	
		$5 \cdot 10^{-5} \cdot R$		
		$6 \cdot 10^{-5} \cdot R$		
		$7 \cdot 10^{-3} \cdot R$		
		$1,5 \cdot 10^{-2} \cdot R$		
		$2,5 \cdot 10^{-2} \cdot R$		
			R = Ölçülen Measured Value (With 5700A)	
			R = Measured Value (With Calibrated Resistance Set)	

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DC Resistance Sources and Standards DC Resistance Standard Calibrator DC Current Shunt Resistance Boxes	$100 \mu\Omega \leq R < 10 \text{ m}\Omega$	100 μA 20 A 1 mA 5,10,15,20 A 10 mA 5,10,15,20 A	$5,5 \cdot 10^{-5}R$	R=Measure Value Comparision with reference resistors
DC Resistance Standard Calibrator Resistance DC Current Shunt Resistance Box	$10 \text{ m}\Omega \leq R < 100 \text{ m}\Omega$	10 mA 5,10,15,20 A $I_{\max} = 1 \text{ A} (R_s = 100 \text{ m})$	$5,5 \cdot 10^{-5} R$	
DC Resistance Standard Calibrator Resistance DC Current Shunt Resistance Box	$100 \text{ m}\Omega \leq R < 1 \Omega$	$I_{\max} = 1 \text{ A} (R_s = 100 \text{ m})$ $I_{\max} = 320 \text{ mA} (R_s = 1)$	$1 \cdot 10^{-5} R$	

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DC Resistance Standard Calibrator Resistance DC Current Shunt Resistance Box	$1 \Omega \leq R < 100\Omega$	$I_{\max} = 320 \text{ mA}$ ($R_s=1\Omega$) $I_{\max} = 100 \text{ mA}$ ($R_s=10\Omega$) $I_{\max} = 32 \text{ mA}$ ($R_s=100\Omega$)	$7 \cdot 10^{-6} \cdot R$	R=Measure Value Comparision with reference resistors
	$100\Omega \leq R < 10 \text{ k}\Omega$	$I_{\max} = 32 \text{ mA}$ ($R_s=100\Omega$) $I_{\max} = 10 \text{ mA}$ ($R_s=1\text{k}\Omega$) $I_{\max}=3,2\text{mA}$ ($R_s=10\text{k}\Omega$)	$5 \cdot 10^{-6} \cdot R$	
	$10 \text{ k}\Omega \leq R \leq 100 \text{ k}\Omega$	$I_{\max} = 3,2 \text{ mA}$ ($R_s=10\text{k}\Omega$) $V_{\max}= 100 \text{ V}$ ($R_s=100\text{k}\Omega$)	$5 \cdot 10^{-6} \cdot R$	
	$100 \text{ k}\Omega < R \leq 10 \text{ M}\Omega$	$V_{\max}=100\text{V}$ ($R_s=100\text{k}\Omega$) $V_{\max}=320\text{V}$ ($R_s=1\text{M}\Omega$)	$1,5 \cdot 10^{-5} R$	
	$10\text{M}\Omega < R \leq 100 \text{ M}\Omega$	$V_{\max}=320 \text{ V}$ ($R_s=1\text{M}\Omega$) $V_{\max}=1000\text{V}$ ($R_s=10\text{M}\Omega$) $V_{\max}=1000\text{V}$ ($R_s=100\text{M}\Omega$)	$2,0 \cdot 10^{-5} R$	

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AC Current (<20 A) AC Current Measuring Devices Ölçerler Multimeter: AC Current AC Clampmeter	100 µA ≤ I < 220 µA	10 Hz ≤ f < 10 kHz	1·10 ⁻³ · I	I = Measured Value With 5700A
	1 mA ≤ I < 2,2 mA	10 Hz ≤ f < 20 Hz	8·10 ⁻⁴ · I	
		20 Hz ≤ f < 40 Hz	4·10 ⁻⁴ · I	
		40 Hz ≤ f < 1 kHz	9·10 ⁻⁵ · I + 0,2 µA	
		1 kHz ≤ f < 5 kHz	8 ·10 ⁻⁴ · I + 1 µA	
		5 kHz ≤ f ≤ 10 kHz	2 ·10 ⁻³ · I + 2,5 µA	
	2,2 mA ≤ I < 22 mA	10 Hz ≤ f < 20 Hz	8·10 ⁻⁴ · I + 2µA	
		20 Hz ≤ f < 40 Hz	4 ·10 ⁻⁴ · I + 1,5 µA	
		40 Hz ≤ f < 1 kHz	2·10 ⁻⁴ · I + 0,8 µA	
		1 kHz ≤ f < 5 kHz	8·10 ⁻⁴ · I + 5,5 µA	
		5 kHz ≤ f ≤ 10 kHz	2·10 ⁻³ · I + 13 µA	
	22 mA ≤ I < 220 mA	10 Hz ≤ f < 20 Hz	7,5 ·10 ⁻⁴ · I + 20 µA	
		20 Hz ≤ f < 40 Hz	4·10 ⁻⁴ · I + 13 µA	
		40 Hz ≤ f < 1 kHz	2·10 ⁻⁴ · I + 8 µA	
		1 kHz ≤ f < 5 kHz	8·10 ⁻⁴ · I + 55 µA	
		5 kHz ≤ f ≤ 10 kHz	2,5 ·10 ⁻³ · I + 120 µA	
	220 mA ≤ I < 2,2 A	20 Hz ≤ f < 1 kHz	7·10 ⁻⁴ · I + 190 µA	
		1 kHz ≤ f < 5 kHz	8,5·10 ⁻⁴ · I + 270 µA	
		5 kHz ≤ f ≤ 10 kHz	9·10 ⁻³ · I + 2,1 mA	
	2,2 A ≤ I < 3 A	45 Hz ≤ f < 1 kHz	5,1·10 ⁻⁴ · I	
1 kHz ≤ f < 5 kHz		1,4·10 ⁻³ · I		
2,2 A ≤ I < 3 A	5 kHz ≤ f < 10 kHz	2,2·10 ⁻² · I		
	45 Hz ≤ f < 100 Hz	6,3·10 ⁻⁴ · I + 4 mA		
2,2 A ≤ I < 3 A	100 Hz ≤ f < 1 kHz	1,0·10 ⁻³ · I + 4 mA	I = Measured Value With 5520A	
		1 kHz ≤ f < 5 kHz		2,5·10 ⁻² · I + 75 mA
3 A ≤ I < 11 A	45 Hz ≤ f < 100 Hz	1,2·10 ⁻³ · I + 15 mA		
	100 Hz ≤ f < 1 kHz	1,4·10 ⁻³ · I + 20 mA		
3 A ≤ I < 11 A	1 kHz ≤ f < 5 kHz	2,4·10 ⁻³ · I + 30 mA		
11 A ≤ I ≤ 20,5 A	30 Hz ≤ f < 1kHz	1·10 ⁻³ · I + 3 mA		
		1 kHz ≤ f ≤ 5 kHz		3·10 ⁻³ · I + 15 mA
11 A ≤ I ≤ 20,5 A	10,40,500,1k,5kHz	5·10 ⁻⁴ · I		
11 A ≤ I ≤ 20,5 A			I=Ölçülen Değer 5700A+5220A	

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AC Voltage (< 1100 V) AC Voltage Measuring Device Multimeter: AC Voltage AC Measuring Standard AC Voltmeter	2 mV ≤ U < 2,2 mV	10 Hz ≤ f < 20 Hz	$3 \cdot 10^{-3} \cdot U + 6 \mu V$	U= Measured Value With 5700A	
		20 Hz ≤ f < 40 Hz	$2,5 \cdot 10^{-3} \cdot U + 5 \mu V$		
		40 Hz ≤ f < 20 kHz	$2,5 \cdot 10^{-3} \cdot U + 5 \mu V$		
		20 kHz ≤ f < 50 kHz	$2,5 \cdot 10^{-3} \cdot U + 6 \mu V$		
		50 kHz ≤ f < 100 kHz	$4,2 \cdot 10^{-3} \cdot U + 8 \mu V$		
		100 kHz ≤ f < 300 kHz	$7,5 \cdot 10^{-3} \cdot U + 15 \mu V$		
		300 kHz ≤ f < 500 kHz	$1,5 \cdot 10^{-2} \cdot U + 30 \mu V$		
		500 kHz ≤ f < 1 MHz	$1,5 \cdot 10^{-2} \cdot U + 30 \mu V$		
		2,2 mV ≤ U < 22 mV	10 Hz ≤ f < 20 Hz		$9 \cdot 10^{-4} \cdot U + 6 \mu V$
			20 Hz ≤ f < 40 Hz		$5 \cdot 10^{-4} \cdot U + 6 \mu V$
			40 Hz ≤ f < 20 kHz		$4 \cdot 10^{-4} \cdot U + 6 \mu V$
			20 kHz ≤ f < 50 kHz		$7 \cdot 10^{-4} \cdot U + 6 \mu V$
	50 kHz ≤ f < 100 kHz		$1,2 \cdot 10^{-3} \cdot U + 9 \mu V$		
	100 kHz ≤ f < 300 kHz		$2,0 \cdot 10^{-3} \cdot U + 15 \mu V$		
	300 kHz ≤ f < 500 kHz		$3,0 \cdot 10^{-3} \cdot U + 30 \mu V$		
	500 kHz ≤ f < 1 MHz		$3,0 \cdot 10^{-3} \cdot U + 30 \mu V$		
	22 mV ≤ U < 220 mV		10 Hz ≤ f < 20 Hz		$7 \cdot 10^{-4} \cdot U + 26 \mu V$
			20 Hz ≤ f < 40 Hz		$2,5 \cdot 10^{-4} \cdot U + 6 \mu V$
			40 Hz ≤ f < 20 kHz		$1,5 \cdot 10^{-4} \cdot U + 8 \mu V$
			20 kHz ≤ f < 50 kHz		$4 \cdot 10^{-4} \cdot U + 15 \mu V$
		50 kHz ≤ f < 100 kHz	$9 \cdot 10^{-4} \cdot U + 30 \mu V$		
		100 kHz ≤ f < 300 kHz	$1,2 \cdot 10^{-3} \cdot U + 36 \mu V$		
		300 kHz ≤ f < 500 kHz	$2 \cdot 10^{-3} \cdot U + 65 \mu V$		
		500 kHz ≤ f < 1 MHz	$4 \cdot 10^{-3} \cdot U + 100 \mu V$		
220 mV ≤ U < 2,2 V		10 Hz ≤ f < 20 Hz	$6 \cdot 10^{-4} \cdot U + 200 \mu V$		
		20 Hz ≤ f < 40 Hz	$3 \cdot 10^{-4} \cdot U + 65 \mu V$		
		40 Hz ≤ f < 20 kHz	$9 \cdot 10^{-5} \cdot U + 25 \mu V$		
		20 kHz ≤ f < 50 kHz	$1,5 \cdot 10^{-4} \cdot U + 45 \mu V$		
	50 kHz ≤ f < 100 kHz	$5 \cdot 10^{-4} \cdot U + 250 \mu V$			
	100 kHz ≤ f < 300 kHz	$5 \cdot 10^{-4} \cdot U + 250 \mu V$			
220 mV ≤ U < 2,2 V	10 Hz ≤ f < 20 Hz	$1,2 \cdot 10^{-3} \cdot U + 600 \mu V$			
	20 Hz ≤ f < 40 Hz	$2,6 \cdot 10^{-3} \cdot U + 1,3 mV$			
	40 Hz ≤ f < 20 kHz				

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		$20 \text{ kHz} \leq f < 50 \text{ kHz}$ $50 \text{ kHz} \leq f < 100 \text{ kHz}$ $100 \text{ kHz} \leq f < 300 \text{ kHz}$ $300 \text{ kHz} \leq f < 500 \text{ kHz}$ $500 \text{ kHz} \leq f < 1 \text{ MHz}$		
AC Voltage (< 1100 V) AC Voltage Measuring Device Multimeter: AC Voltage AC Measuring Standard AC Voltmeter	$2,2 \text{ V} \leq U < 22 \text{ V}$ $22 \text{ V} \leq U < 220 \text{ V}$ $220 \text{ V} \leq U \leq 1000 \text{ V}$	$10 \text{ Hz} \leq f < 20 \text{ Hz}$ $20 \text{ Hz} \leq f < 40 \text{ Hz}$ $40 \text{ Hz} \leq f < 20 \text{ kHz}$ $20 \text{ kHz} \leq f \leq 50 \text{ kHz}$ $50 \text{ kHz} \leq f < 100 \text{ kHz}$ $100 \text{ kHz} \leq f < 300 \text{ kHz}$ $300 \text{ kHz} \leq f < 500 \text{ kHz}$ $500 \text{ kHz} \leq f < 1 \text{ MHz}$ $10 \text{ Hz} \leq f < 20 \text{ Hz}$ $20 \text{ Hz} \leq f < 40 \text{ Hz}$ $40 \text{ Hz} \leq f < 20 \text{ kHz}$ $20 \text{ kHz} \leq f \leq 50 \text{ kHz}$ $50 \text{ kHz} \leq f < 100 \text{ kHz}$ $15 \text{ Hz} \leq f < 50 \text{ Hz}$ $50 \text{ Hz} \leq f \leq 1 \text{ kHz}$	$5 \cdot 10^{-4} \cdot U + 2 \text{ mV}$ $2 \cdot 10^{-4} \cdot U + 650 \mu\text{V}$ $9 \cdot 10^{-5} \cdot U + 230 \mu\text{V}$ $1,5 \cdot 10^{-4} \cdot U + 440 \mu\text{V}$ $1,5 \cdot 10^{-4} \cdot U + 45 \mu\text{V}$ $3 \cdot 10^{-4} \cdot U + 90 \mu\text{V}$ $6 \cdot 10^{-3} \cdot U + 2,6 \text{ mV}$ $3,1 \cdot 10^{-3} \cdot U + 7,5 \text{ mV}$ $6 \cdot 10^{-4} \cdot U + 20 \text{ mV}$ $2 \cdot 10^{-4} \cdot U + 7 \text{ mV}$ $9 \cdot 10^{-5} \cdot U + 3 \text{ mV}$ $2,5 \cdot 10^{-4} \cdot U + 9 \text{ mV}$ $5,5 \cdot 10^{-4} \cdot U + 20$ $4,5 \cdot 10^{-4} \cdot U + 110 \text{ mV}$ $9 \cdot 10^{-5} \cdot U + 25 \text{ mV}$	U= Measured Value With 5700A
DC Power DC Powermeters DC Watmeters	$0,1 \text{ W} \leq P < 10 \text{ kW}$ $10 \text{ kW} \leq P \leq 20 \text{ kW}$	$100 \text{ mA} - 10 \text{ A}$ $1 \text{ V} - 1000 \text{ V}$ $10 \text{ A} - 20 \text{ A}$ $1 \text{ V} - 1000 \text{ V}$	$6,5 \cdot 10^{-4} \cdot P$ $8,5 \cdot 10^{-4} \cdot P$	P= Measured Value With 5520A
AC Power and Energy: Active Power: Mono Phase Powermeter, Wattmeter	$0,1 \text{ W} \leq P \leq 10 \text{ kW}$ $10 \text{ kW} \leq P \leq 20 \text{ kW}$	$0,1 \text{ A} \leq I < 10 \text{ A}$ $1 \text{ V} \leq V < 1000 \text{ V}$ $10 \text{ Hz} \leq f \leq 1 \text{ kHz}$ $10 \text{ A} \leq I < 20 \text{ A}$ $500 \text{ V} \leq V < 1000 \text{ V}$ $10 \text{ Hz} \leq f \leq 1 \text{ kHz}$	$1,5 \cdot 10^{-3} \cdot P$ $2,5 \cdot 10^{-3} \cdot P$	P= Measured Value With 5520A

MEASURAND /DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
AC Voltage (< 1100 V) AC Voltage Sources AC Voltage Sources AC Kalibrator	2 mV ≤ U < 10mV	40 Hz ≤ f < 1 kHz 1 kHz ≤ f < 20 kHz	4 · 10 ⁻⁴ · U + 2 μV 5 · 10 ⁻⁴ · U + 2 μV	U=Measured Value With 3458A
	10 mV ≤ U < 100 mV	1 Hz ≤ f < 40 Hz	1,3 · 10 ⁻⁴ · U + 6 μV	
		40 Hz ≤ f < 1 kHz	1,1 · 10 ⁻⁴ · U + 4 μV	
		1 kHz ≤ f < 20 kHz	2,1 · 10 ⁻⁴ · U	
		20 kHz ≤ f ≤ 50 kHz	4 · 10 ⁻⁴ · U + 6 μV	
		50 kHz < f ≤ 100 kHz	1,1 · 10 ⁻³ · U + 21 μV	
		1 Hz ≤ f < 40 Hz	1,4 · 10 ⁻⁴ · U + 60 μV	
	100 mV ≤ U < 1V	40 Hz ≤ f < 1 kHz	1,2 · 10 ⁻⁴ · U + 35 μV	
		1 kHz ≤ f < 20 kHz	2 · 10 ⁻⁴ · U + 45 μV	
		20 kHz ≤ f ≤ 50 kHz	4 · 10 ⁻⁴ · U + 60 μV	
		50 kHz ≤ f < 100 kHz	1,1 · 10 ⁻³ · U + 210 μV	
		100 kHz ≤ f < 300 kHz	3,6 · 10 ⁻³ · U + 470 μV	
		300 kHz ≤ f < 1 MHz	1,2 · 10 ⁻² · U + 1,5 mV	
	1V ≤ U < 10V	1 Hz ≤ f < 40 Hz	1,3 · 10 ⁻⁴ · U + 600 μV	
		40 Hz ≤ f < 1 kHz	1,4 · 10 ⁻⁴ · U + 350 μV	
		1 kHz ≤ f < 20 kHz	2,2 · 10 ⁻⁴ · U + 650 μV	
20 kHz ≤ f ≤ 50 kHz		4,0 · 10 ⁻⁴ · U + 850 μV		
50 kHz ≤ f < 100 kHz		1,2 · 10 ⁻³ · U + 3,5 mV		
100 kHz ≤ f < 300 kHz		3,8 · 10 ⁻³ · U + 6 mV		
10V ≤ U < 100V	300 kHz ≤ f < 1 MHz	1,2 · 10 ⁻² · U + 15 mV		
	1 Hz ≤ f < 40 Hz	2,7 · 10 ⁻⁴ · U + 7 mV		
	40 Hz ≤ f < 1 kHz	2,7 · 10 ⁻⁴ · U + 5 mV		
	1 kHz ≤ f < 20 kHz	4,5 · 10 ⁻⁴ · U + 7 mV		
	20 kHz ≤ f ≤ 50 kHz	1,5 · 10 ⁻² · U + 170 mV		
	50 kHz ≤ f < 100 kHz	5,5 · 10 ⁻⁴ · U + 100 mV		
100 V ≤ U ≤ 1000 V	1 Hz ≤ f ≤ 40 Hz	1,1 · 10 ⁻⁴ · U + 40 mV		
	40 Hz ≤ f < 1 kHz	1,9 · 10 ⁻⁴ · U + 40 mV		
	1 kHz ≤ f < 20 kHz			
	20 kHz ≤ f < 50 kHz			

MEASURAND /DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES	
Capacitance Capacitance Measuring Devices LCR Meter:	1 nF	f = 1 kHz	$1.8 \cdot 10^{-4} \cdot C$	C = Measured Value	
	10 nF		$1.8 \cdot 10^{-4} \cdot C$		
	100 nF		$1.8 \cdot 10^{-4} \cdot C$		
	1 μ F		$1.8 \cdot 10^{-4} \cdot C$		
		10 Hz- 10 kHz			C = Measured Value With Fluke 5520A
	$0.22 \leq C < 0.3999$	10 Hz- 10 kHz	% 5.0		
	nF	10 Hz- 3000 Hz	% 2.5		
	$0.4 \leq C < 1.0999$ nF	10 Hz- 1000 Hz	% 1.3		
	$1.1 \leq C < 3.2999$ nF	10 Hz- 1000 Hz	% 0.6		
	$3.3 \leq C < 10.9999$ nF	10 Hz- 1000 Hz	% 1.0		
	$11 \leq C < 32.999$ nF	10 Hz- 600 Hz	% 0.5		
	$33 \leq C < 109.999$ nF	10 Hz- 300 Hz	% 0.5		
	nF	10 Hz- 150 Hz	% 0.5		
	$110 \leq C < 329.999$ nF	10 Hz- 120 Hz	% 0.5		
	nF	10 Hz- 80 Hz	% 0.6		
	$0.33 \leq C < 1.09999$ μ F		% 0.6		
$1.1 \leq C < 3.29999$ μ F					
$3.3 \leq C < 10.9999$ μ F					
$11 \leq C < 32.999$ μ F					
$33 \leq C < 109.999$ μ F					

MEASURAND /DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
Inductance L Inductance Measuring Device LCR Meter	100 μ H	100 Hz	$1,2 \cdot 10^{-3} \cdot L$	L =Measured Value
		200 Hz	$4 \cdot 10^{-4} \cdot L$	
		400 Hz	$4 \cdot 10^{-4} \cdot L$	
		1 kHz	$4 \cdot 10^{-4} \cdot L$	
		10 kHz	$5 \cdot 10^{-4} \cdot L$	
	1 mH	100 Hz	$3,5 \cdot 10^{-4} \cdot L$	
		200 Hz	$3 \cdot 10^{-4} \cdot L$	
		400 Hz	$3 \cdot 10^{-4} \cdot L$	
		1 kHz	$3 \cdot 10^{-4} \cdot L$	
		10 kHz	$3,5 \cdot 10^{-4} \cdot L$	
	10 mH	100 Hz	$3 \cdot 10^{-4} \cdot L$	
		200 Hz	$3 \cdot 10^{-4} \cdot L$	
		400 Hz	$3 \cdot 10^{-4} \cdot L$	
		1 kHz	$3 \cdot 10^{-4} \cdot L$	
		10 kHz	$4 \cdot 10^{-4} \cdot L$	
	100 mH	100 Hz	$3 \cdot 10^{-4} \cdot L$	
		200 Hz	$3 \cdot 10^{-4} \cdot L$	
		400 Hz	$3 \cdot 10^{-4} \cdot L$	
		1 kHz	$3 \cdot 10^{-4} \cdot L$	
		4 kHz	$3 \cdot 10^{-4} \cdot L$	
1 H	10 kHz	$3,5 \cdot 10^{-4} \cdot L$		
	100 Hz	$3 \cdot 10^{-4} \cdot L$		
	200 Hz	$3 \cdot 10^{-4} \cdot L$		
	400 Hz	$3 \cdot 10^{-4} \cdot L$		
	1 kHz	$3 \cdot 10^{-4} \cdot L$		

MEASURAND/D EVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
Time and Frequency Frequency Frequency Sources Frequency Source	$1 \text{ Hz} \leq f \leq 10 \text{ Hz}$ $10 \text{ Hz} \leq f < 100 \text{ Hz}$ $100 \text{ Hz} \leq f < 1 \text{ kHz}$ $1 \text{ kHz} \leq f < 10 \text{ kHz}$ $10 \text{ kHz} \leq f < 100 \text{ kHz}$ $100 \text{ kHz} \leq f < 230$ MHz $230 \text{ MHz} \leq f \leq 40$ GHz	Gate Time 10 s Amplitude $\leq 5V_{\text{rms}}$	$5 \cdot 10^{-6} \cdot f$ $1 \cdot 10^{-6} \cdot f$ $1 \cdot 10^{-7} \cdot f$ $1 \cdot 10^{-8} \cdot f$ $1 \cdot 10^{-9} \cdot f$ $2 \cdot 10^{-10} \cdot f$ $5 \cdot 10^{-11} \cdot f$	f : Measured Frequency [Hz] With Counter Synchronized via rubidium oscillator
Time and Frequency Frequency Frequency Counters Frequency Counter	$10 \text{ Hz} \leq f < 100 \text{ Hz}$ $100 \text{ Hz} \leq f < 1 \text{ kHz}$ $1 \text{ kHz} \leq f < 100 \text{ kHz}$ $100 \text{ kHz} \leq f \leq$ 40GHz	Gate Time 10 s Amplitude $\leq 5 V_{\text{rms}}$	$1 \cdot 10^{-7} \cdot f$ $1 \cdot 10^{-8} \cdot f$ $1 \cdot 10^{-9} \cdot f$ $1 \cdot 10^{-10} \cdot f$	f : Measured Frequency [Hz] With Counter Synchronized via rubidium oscillator
Time and Frequency Time Interval Time Interval Measuring Devices	$100 \text{ ps} \leq t < 1 \mu\text{s}$ $1 \mu\text{s} \leq t < 100 \mu\text{s}$ $100 \mu\text{s} \leq t < 1 \text{ ms}$ $1 \text{ ms} \leq t < 10 \text{ ms}$ $10 \text{ ms} \leq t < 100 \text{ ms}$ $100 \text{ ms} \leq t < 1 \text{ s}$ $1 \text{ s} \leq t < 10 \text{ s}$ $10 \text{ s} \leq t < 100 \text{ s}$ $100 \text{ s} \leq t \leq 1000 \text{ s}$	Gate Time 10 s Amplitude $\leq 5 V_{\text{rms}}$	$1 \cdot 10^{-10} \cdot t$ $1 \cdot 10^{-9} \cdot t$ $1 \cdot 10^{-8} \cdot t$ $1 \cdot 10^{-7} \cdot t$ $1 \cdot 10^{-6} \cdot t$ $1 \cdot 10^{-5} \cdot t$ $1 \cdot 10^{-4} \cdot t$ $1 \cdot 10^{-3} \cdot t$ $1 \cdot 10^{-2} \cdot t$	t : Measured Time Interval [s] With Counter Synchronized via rubidium oscillator

MEASURAND/DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
Time and Frequency Time Interval Stopwatches	$-30,00 \text{ s/day} \leq t \leq +30,00$ $\text{s/day } 1 \text{ s} \leq t \leq 3600 \text{ s}$		$0,04 \text{ s/g}$ 100 ms	<i>t</i> : Measured daily deviation [s/day] or time Interval [s] Direct reading via reference calibrator Comparison with reference frequency counter
Time Frequency Frequency Frequency Counter Optical Tachometers	$60 \text{ rpm} \leq \omega \leq 99999 \text{ rpm}$	$r = 0,001 \text{ rpm}$ $r = 0,01 \text{ rpm}$ $r = 0,1 \text{ rpm}$ $r = 1 \text{ rpm}$ $r = 10 \text{ rpm}$	$0,001 \text{ rpm}$ $0,006 \text{ rpm}$ $0,06 \text{ rpm}$ $0,6 \text{ rpm}$ 6 rpm	Measuring frequency using laser led ω : Measured Value [rpm] <i>r</i> : Resolution [rpm]

BALANCES

Nonautomatic Weighing Instruments	$m \leq 300 \text{ g}$ $m \leq 10 \text{ kg}$ $m \leq 5 \text{ kg}$ $m \leq 150 \text{ kg}$	With E2 Class Weights With F1 Class Weights With F2 Class Weights With M1 Class Weights	$2,0 \cdot 10^{-6}$ $6,2 \cdot 10^{-6}$ $2,0 \cdot 10^{-5}$ $8,5 \cdot 10^{-5}$	With procedure written according to Euromet Cg-18 v.04 guide <i>m</i> : balance capacity (Weight)
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MATERIAL TESTING MACHINES

Concrete Test Hammer	10 N/mm ² ≤ P ≤ 100 N/mm ²	TS EN 12504-2	3%	With reference anvil
Fatigue Testing Machine Dynamic Calibration	Fatigue Testing Machine Dynamic Calibration	MIL STD 1312B ASTM E467 ISO 4965-2	% 0,32	With reference load cells
Tensile-Compression Bending-Spring Force Test and Concrete Test Machine Calibration	1N≤F≤1MN 1N≤F≤ 2MN 1mN≤F≤50N 1N≤F≤220N 1N≤F≤3MN	TS EN ISO 7500-1 ASTM E 4 TS EN 12390-4	% 0,16 % 0,16 % 0,10 % 0,10 % 0,32	Compression (With 0.5 Class Load Cell) Tensile (With 0.5 Class Load Cell) Tensile (With E2 class weights) Compression (With F1 Class Weight) Compression ((With 1 Class Load Cell))
Mechanical Energy Charpy Impact Testing Machine Calibration	Nominal Energy 0,5J ≤ A _P ≤ 750J	TS EN ISO 148-2 ASTM E23 DIN 51222	Forcet: 0,12% Pendulum Length: 1mm Angle: 0,03° Time:0,04s	Measurement uncertainty is calculated for the following parameters. 1 - Resonance status. 2 - Potential Energy. 3 - Indicator deviation.
Uzunluk ölçer Extensometre	0 mm ≤ L ≤ 60 mm	TS EN ISO 9513	1,5 10 ⁻³ ×L Not lower than 0,5 μm	Measurment Method: Incremental

HARDNESS

MEASURAND /DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
Brinell Vickers Rockwell Hardness Measuring Devices	60HB≤HB≤450HB 200HV≤HV≤840HV 20 HRA ≤ HRA ≤ 65 HRA 66 HRA ≤ HRA ≤ 88 HRA 20 HRB ≤ HRB ≤ 55 HRB 56 HRB ≤ HRB ≤ 100 HRB 20 HRC ≤ HRC ≤ 55 HRC 56 HRC ≤ HRC ≤ 70 HRC 12 HRT ≤ HRT ≤ 93 HRT 20 HRN ≤ HRT ≤ 90 HRN	TS EN ISO 6506-2 TS EN ISO 6507-2 TS EN ISO 6508-2	2%HB 2%HV 1,0HRA 0,5HRA 1,5HRB 1,0HRB 1,0HRC 0,5HRC 2,0HRT 1,0HRN	These value are uncertainties obtained by undirect calibration with hardness blocks
Hardness measuring Devices Trace Depth Inspectetion	0mm ≤ L ≤ 10mm	TS EN ISO 6507-2 TS EN ISO 6506-2	1,5 10 ⁻³ ×L Lower than 0,5 μm	With object micrometer
Shoremeter	<i>Shore A</i> <i>Shore D</i>	Direct Calibration	1 Shore A 1 Shore D	ISO 18898 ASTM D2240

TEMPERATURE

MEASURAND /DEVICE	MEASURING RANGE	CONDITIONS	MEASUREMENT CAPABILITY / UNCERTAINTY	NOTES
Ice Point	0°C	Comparison Method	±0,030°C	Comparison of 2 thermometers
Resistance Thermometer	-70°C ≤ T < 5°C	Comparison method (Liquid Bath)	0,060 °C	t:Measured Temperature Including Ice point Uncertainty
	5°C ≤ T < 85°C		0,045 °C	
	85°C ≤ T ≤ 250°C		0,080 °C	
Liquid Glass Thermometers	-70°C ≤ T < 5°C	Comparison method (Liquid Bath)	0,060 °C	t:Measured Temperature Including Ice point Uncertainty
	5°C ≤ T < 85°C		0,045 °C	
	85°C ≤ T ≤ 250°C		0,080 °C	
Thermocouples	-70°C ≤ T < 5°C	Comparison method	0,060 °C	t:Measured Temperature With liquid bath and reference PRT
	5°C ≤ T < 85°C		0,045 °C	
	85°C ≤ T ≤ 250°C		0,080 °C	
	600°C ≤ T < 1100°C		2,5°C	
	1100°C ≤ T ≤ 1550°C		3,0°C	
Digital/Analog Thermometers	-70°C ≤ T < 5°C	Comparison method	0,060 °C	t:Measured Value including ice point uncertainty With liquid bath and reference PRT
	5°C ≤ T < 85°C		0,045 °C	
	85°C ≤ T ≤ 250°C		0,080 °C	
	600°C ≤ T < 1100°C		2,5°C	
	1100°C ≤ T ≤ 1550°C		3,0°C	

				With dry block calibrator and thermocouple
Detection of temperature distribution of the temperature controlled volume (sterilizer, incubator, oven, air conditioning cabinet, freezers, cold rooms, water baths etc.	$-70^{\circ}\text{C} \leq T \leq 100^{\circ}\text{C}$ $100^{\circ}\text{C} < T \leq 175^{\circ}\text{C}$ $\%20 \text{ rh} \leq \text{RH} \leq \%80 \text{ rh}$	At site calibration using mobile calibration system Distribution of temperature and humidity	$\pm 0,7^{\circ}\text{C}$ $\pm 1,0^{\circ}\text{C}$ $\%3,0 \text{ rh}$	With procedure written according to TS EN 60066-3-1 1, Ts EN 60068_3_5, EURAMET cg.20, DAkks DKD R_5-7 standarts
Ash Furnace	$250^{\circ}\text{C} \leq T < 550^{\circ}\text{C}$ $550^{\circ}\text{C} \leq T \leq 1200^{\circ}\text{C}$	Temperature distribution	$1,5^{\circ}\text{C}$ $3,5^{\circ}\text{C}$	t: Measured Value Temperature distribution Calibration both on site and in laboratory t: Measured value

Torque

Toqrque Wrench	$0,2 \text{ N}\cdot\text{m} \leq M \leq 1000 \text{ N}\cdot\text{m}$	Temperature: 18 °C between 28°C Minimum distribution ± 1 °C RH < 90 %	% 0,2	Procedurs written according to TS ISO 6789-1ve TS ISO 6789-2 standarts. Calibration for both directions
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Dimension

Outside Micrometer	$L \leq 25 \text{ mm}$ $25 \text{ mm} < L \leq 300 \text{ mm}$ $300 \text{ mm} < L \leq 1000 \text{ mm}$	$r: 0,01 \text{ mm}$ $r: 0,001 \text{ mm}$ $r: 0,0001 \text{ mm}$ $r: 0,01 \text{ mm}$ $r: 0,001 \text{ mm}$ $r: 0,01 \text{ mm}$	$3,1 + 5 \cdot L) \mu\text{m}$ $(1,4 + 9 \cdot L) \mu\text{m}$ $(1,2 + 11 \cdot L) \mu\text{m}$ $(3,1 + 26 \cdot L) \mu\text{m}$ $(1,4 + 30 \cdot L) \mu\text{m}$ $(3,1 + 31 \cdot L) \mu\text{m}$	VDI/VDE/DGQ 2618 Part 10.1 L: Measured value (m) r: çresolution
Depth Micrometer	$L \leq 300 \text{ mm}$	$r: 0,01 \text{ mm}$	$(3,1 + 25 \cdot L) \mu\text{m}$	VDI/VDE/DGQ 2618 Part 10.5 <i>L: Measured Value(m)</i> <i>r: Resolution</i>
Internal Micrometers with 2 Point Contact	$25 \text{ mm} \leq L \leq 40 \text{ mm}$	$r: 0,01 \text{ mm}$ $r: 0,001 \text{ mm}$	$(14,2 + 5 \cdot L) \mu\text{m}$ $(11,6 + 6 \cdot L) \mu\text{m}$	VDI/VDE/DGQ 2618 Part 10.7 <i>L: Measured Value(m)</i> <i>r: Resolution</i>
Internal Micrometers with 2 Point Contact	$5 \text{ mm} \leq L \leq 40 \text{ mm}$	$r: 0,01 \text{ mm}$ $r: 0,005 \text{ mm}$ $r: 0,001 \text{ mm}$	$(14,2 + 5 \cdot L) \mu\text{m}$ $(12,3 + 6 \cdot L) \mu\text{m}$ $(11,6 + 6 \cdot L) \mu\text{m}$	VDI/VDE/DGQ 2618 Part 10.8 L: Measured Value (m) r: Resolution

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Caliper	L ≤ 200 mm 200 mm < L ≤ 500 mm 500 mm < L ≤ 1000 mm	r: 0,01 mm r: 0,02 mm r: 0,05 mm r: 0,1 mm r: 0,01 mm r: 0,02 mm r: 0,05 mm r: 0,1 mm r: 0,01 mm r: 0,02 mm r: 0,05 mm r: 0,1 mm	(10 + 11 · L) μm (12,9 + 9 · L) μm (29,4 + 4 · L) μm (58 + 2 · L) μm (10 + 21 · L) μm (12,9 + 18 · L) μm (29,4 + 10 · L) μm (58 + 5 · L) μm (10 + 27 · L) μm (12,9 + 25 · L) μm (29,5 + 17 · L) μm (58 + 10 · L) μm	VDI/VDE/DGQ 2618 Part 9.1 Outside diameter Inside diameter, depth, step, level Measurement L: Measured Value(m) r: Resolution
Depth Caliper	L ≤ 300 mm 300 mm < L ≤ 1000 mm	r: 0,01 mm r: 0,02 mm r: 0,05 mm r: 0,1 mm r: 0,01 mm r: 0,02 mm r: 0,05 mm r: 0,1 mm	(10 + 15 · L) μm (13 + 13 · L) μm (29,4 + 6 · L) μm (58 + 3 · L) μm (10 + 27 · L) μm (12,9 + 25 · L) μm (29,4 + 17 · L) μm (58 + 10 · L) μm	VDI/VDE/DGQ 2618 Part 9.2 L: Measured value (m) r: Resolution
Dial Gauge	L ≤ 30 mm	r: 0,001 mm r: 0,002 mm r: 0,01 mm	(1,2 + 1 · L) μm (1,8 + 1 · L) μm (8,2 + 1 · L) μm	VDI/VDE/DGQ 2618 Part 11.1 L: Resolution(m) r: Resolution
Dial Indicator	L ≤ 3 mm	r: 0,01 mm r: 0,002 mm r: 0,001 mm	5,8 μm 1,2 μm 0,7 μm	VDI/VDE/DGQ 2618 Part 11.2 L: Measurement Value(m) r: Resolution
Feeler Gauge	0,01 mm ≤ L ≤ 2 mm		2,0 μm	Thickness Measurement DIN 2275

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Radius Gauge	$1 \text{ mm} \leq d \leq 25 \text{ mm}$		$3,0 \text{ } \mu\text{m}$	Optical Method d: Measured Value(m)
Height Calipper	$L \leq 300 \text{ mm}$ $300 \text{ mm} < L \leq 600 \text{ mm}$	$r=0,001 \text{ mm}$ $r=0,01 \text{ mm}$ $r=0,02 \text{ mm}$ $r=0,05 \text{ mm}$ $r=0,001 \text{ mm}$ $r=0,01 \text{ mm}$ $r=0,02 \text{ mm}$ $r=0,05 \text{ mm}$	$(5,9 + 16 \cdot L) \text{ } \mu\text{m}$ $(10 + 15 \cdot L) \text{ } \mu\text{m}$ $(12,9 + 13 \cdot L) \text{ } \mu\text{m}$ $(29,4 + 6 \cdot L) \text{ } \mu\text{m}$ $(5,9 + 27 \cdot L) \text{ } \mu\text{m}$ $(10 + 23 \cdot L) \text{ } \mu\text{m}$ $(12,9 + 20 \cdot L) \text{ } \mu\text{m}$ $(29,4 + 12 \cdot L) \text{ } \mu\text{m}$	VDI/VDE/DGQ 2618 Part 9.3 L: Measured Value(m) r: Resolution
Thickness Gauge Lever Gauges for external Measurements	$L \leq 100 \text{ mm}$		$(8,4 + 1 \cdot L) \text{ } \mu\text{m}$	Blok Master ile karşılaştırma yöntemiyle L: Ölçülen Değer(m) r: çözünürlük / bölüntü değeri
Dial Gauge	$5 \text{ mm} \leq L \leq 200 \text{ mm}$ $5 \text{ mm} \leq L \leq 100 \text{ mm}$	Outside r: 0,01 mm Outside r: 0,005 mm	$(10 + 11 \cdot L) \text{ } \mu\text{m}$ $(7 + 15 \cdot L) \text{ } \mu\text{m}$	VDI/VDE/DGQ 2618 Bölüm 12.1 VDI/VDE/DGQ 2618 Bölüm
	mm	İnside r: 0,01 mm İnside r: 0,005 mm	$(10 + 11 \cdot L) \text{ } \mu\text{m}$ $(7 + 10 \cdot L) \text{ } \mu\text{m}$	13.1 L: Measured Value (m) r: resolution
Sieve	$L \leq 5 \text{ mm}$	Optical Measurement Method	$3 \text{ } \mu\text{m}$	ISO 3310
	$5 \text{ mm} < L \leq 125 \text{ mm}$	Calipper	$25 \text{ } \mu\text{m}$	ISO 3310
Screw Thread Gauge	$0,35 \text{ mm} \leq L \leq 10 \text{ mm}$		$3 \text{ } \mu\text{m}$	Using Projector Step ve Teeth Height L: Step

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Thickness Gauge (Pasometer)	$L \leq 200$ mm	r: 0,01 mm r: 0,001 mm	$(8,3 + 17 \cdot L)$ μm ($1,4 + 30 \cdot L$) μm	VDI/VDE/DGQ 2618 Part 10.3 L: Measured Value (m) r:Resolution
Tape Measure	$0 \text{ mm} < L \leq 3000$ mm $3000 \text{ mm} < L \leq 5000$ mm $5000 \text{ mm} < L \leq 50000$ mm	r: 1 mm	0,4 mm 0,6 mm $0,5 + 0,12 \cdot L$ mm	Comparision Method / TS 9505 L : Measured Value r : Resolution

Volume

Burette	$1 \text{ mL} \leq V \leq 5 \text{ mL}$ 10 mL 25 mL 50 mL 100 mL	Evacuation	3 μL 6 μL 10 μL 20 μL 20 μL	Procedure written according to TS EN ISO 385 TS ISO 4787 Euramet cg 19 ISO/TR 20461 V: Ölçülen Hacim
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Volumetric Flask	$1 \text{ mL} \leq V \leq 5 \text{ mL}$ 10 mL 20 mL 25 mL 50 mL 100 mL 200 mL 250 mL 500 mL 1000 mL 2000 mL	Filling	6 μL 10 μL 30 μL 30 μL 35 μL 40 μL 50 μL 50 μL 80 μL 0,2 mL 0,3 mL	Procedure written according to TS 1491 EN ISO 1042 TS ISO 4787 Euramet cg 19 ISO/TR 20461 V: Measured Volume
Graudated Cylinder	5 mL 10 mL 25 mL 50 mL 100 mL 250 mL 500 mL 1000 mL 2000 mL	Filling	6 μL 30 μL 50 μL 60 μL 0,1 mL 0,2 mL 0,4 mL 1 mL 2 mL	Procedure written according to TS EN ISO 4788 TS ISO 4787 Euramet cg 19 ISO/TR 20461
Picnometer	$1 \text{ mL} \leq V \leq 5 \text{ mL}$ $10 \text{ mL} \leq V \leq 100 \text{ mL}$	Filling	6 μL 20 μL	Procedure written according to TS ISO 3507 TS ISO 4787 Euramet cg 19 ISO/TR 20461 TS EN ISO 2811

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<p>One Mark Volumetric Pipette</p>	<p>$0,1 \text{ ml} \leq V \leq 5 \text{ mL}$ 10 mL 20mL 25 mL 50 mL 100 mL</p>	<p>Evacuation</p>	<p>3 μL 6 μL 10 μL 10 μL 20 μL 20 μL</p>	<p>Procedure written according to TS 1489 ISO 648 TS EN ISO 835 TS ISO 4787 Euramet cg 19 ISO/TR 20461</p> <p>V: Measured Volume</p>
<p>Piston Pipette</p>	<p>100 μL 200 μL 500 μL 1 mL 2 mL 5 mL 10 mL</p>	<p>Single or multi- channel piston Hand movement or motor driven</p>	<p>0,4 μL 0,4 μL 0,6 μL 3 μL 3 μL 6 μL 20 μL</p>	<p>Procedure written according to TS EN ISO 8655-2 TS EN ISO 8655-6 ISO/TR 20461</p> <p>V: Measured Volume</p>

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Piston Burette	1 mL 2 mL 5 mL 10 mL 20 mL ≤ V ≤ 50 mL 100 mL	Hand movement or motor driven	0,6 µl 2 µl 3 µl 8 µl 11 µl 20 µl	Procedure written according to TS EN ISO 8655-3 TS EN ISO 8655 -6 ISO/TR 20461 V: Measured Volume
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